FORM PTO-1449 U.S. Department of Commerce Patent and Commerce Pate	Docket No.: INTEL1320-1 (P14241X)	Serial No.: 10/675,884
JUL 0 2 2004	Applicants: Berlin et al.	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT	Filing Date: September 29, 2003	Group Art Unit: 1743

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FORM PTO-1449 U.S. Department of Commerce Patent and Trademark Office	Docket No.: INTEL1320-1 (P14241X)	Serial No.: 10/675,149
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